Power MOSFET

60 V, 24 m Ω , 26 A, Single N-Channel

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- These are Pb-Free Devices and RoHS Compliant

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	60	V
Gate-to-Source Voltage	Gate-to-Source Voltage			±20	V
Continuous Drain Cur-		T _{mb} = 25°C	I _D	26	Α
rent $R_{\Psi J-mb}$ (Notes 1, 2, 3, 4)	Steady	T _{mb} = 100°C		19	
Power Dissipation	State	T _{mb} = 25°C	P _D	39	W
R _{ΨJ-mb} (Notes 1, 2, 3)		T _{mb} = 100°C		19	
Continuous Drain Cur-		T _A = 25°C	I _D	8.0	Α
rent R _{θJA} (Notes 1, 3, 4)	Steady State	T _A = 100°C		6.0	
Power Dissipation		T _A = 25°C	P _D	3.6	W
R _{θJA} (Notes 1 & 3)		T _A = 100°C		1.8	
Pulsed Drain Current	T _A = 25	°C, t _p = 10 μs	I _{DM}	130	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	–55 to + 175	°C
Source Current (Body Diode)			Is	32	Α
Single Pulse Drain-to-Source Avalanche Energy (T _J = 25°C, V _{DD} = 24 V, V _{GS} = 10 V, I _{L(pk)} = 20 A, L = 0.1 mH, R _G = 25 Ω)			E _{AS}	20	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Mounting Board (top) - Steady State (Notes 2, 3)	$R_{\Psi J-mb}$	3.9	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	42	

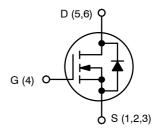
- 1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi (Ψ) is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 4. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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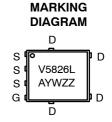
http://onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
60 V	24 mΩ @ 10 V	00.4	
00 V	32 mΩ @ 4.5 V	26 A	



N-CHANNEL MOSFET





Α = Assembly Location

= Year W = Work Week ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NVMFS5826NLT1G	SO-8FL (Pb-Free)	1500 / Tape & Reel
NVMFS5826NLT3G	SO-8FL (Pb-Free)	5000 / Tape & Reel

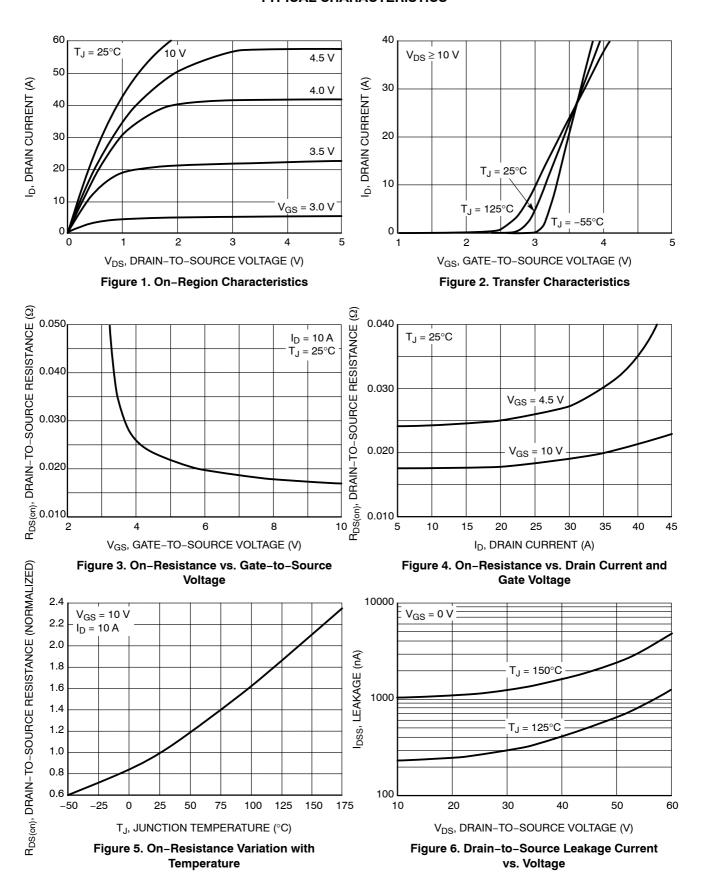
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	-	-			-	-	<u>-</u>
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60			V
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V},$ $T_{J} = 25^{\circ}\text{C}$				1.0	μΑ
		V _{DS} = 60 V	T _J = 125°C			10	1
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	_S = ± 20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \mu A$		1.5		2.5	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I	_D = 10 A		18	24	mΩ
		V _{GS} = 4.5 V, I	_D = 10 A		24	32	1
Forward Transconductance	9FS	V _{DS} = 15 V,	I _D = 5 A		8.0		S
CHARGES AND CAPACITANCES		-					
Input Capacitance	C _{iss}	V _{GS} = 0 V, f =	= 1 MHz,		850		pF
Output Capacitance	C _{oss}	V _{DS} = 2	5 V		85		1
Reverse Transfer Capacitance	C _{rss}	-			50		1
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 48 \text{ V}, I_{D} = 10 \text{ A}$ $V_{GS} = 10 \text{ V}, V_{DS} = 48 \text{ V}, I_{D} = 10 \text{ A}$			9.1		nC
Threshold Gate Charge	Q _{G(TH)}				1.0		
Gate-to-Source Charge	Q_{GS}				3.0		
Gate-to-Drain Charge	Q_{GD}				4.0		
Total Gate Charge	Q _{G(TOT)}				17		nC
SWITCHING CHARACTERISTICS (N	ote 6)						
Turn-On Delay Time	t _{d(ON)}				9.0		
Rise Time	t _r	V _{GS} = 4.5 V, V	_{DS} = 48 V,		32]
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 10 \text{ A}, R_G$	= 2.5 Ω		15		ns
Fall Time	t _f	1			24		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V, I _S = 10 A	T _J = 25°C		0.8	1.2	V
			T _J = 125°C		0.7		
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dls/dt = 100 A/μs, l _S = 10 A			15		
Charge Time	t _a				11		ns
Discharge Time	t _b				4.0		1
Reverse Recovery Charge	Q _{RR}				11		nC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



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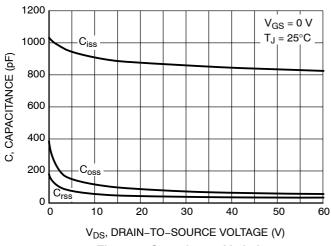


Figure 7. Capacitance Variation

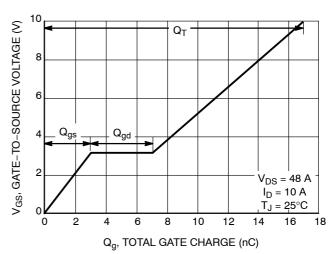


Figure 8. Gate-to-Source Voltage vs. Total Charge

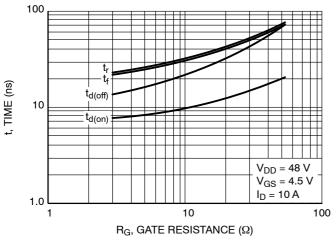


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

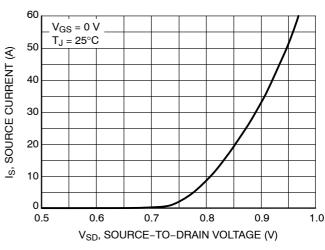


Figure 10. Diode Forward Voltage vs. Current

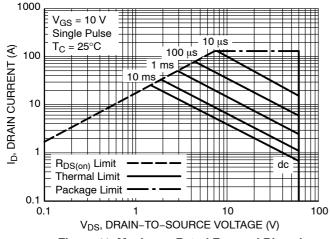


Figure 11. Maximum Rated Forward Biased Safe Operating Area

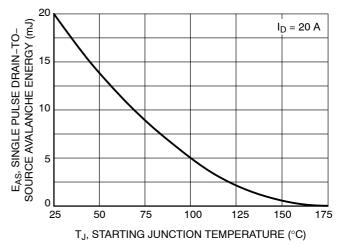


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL CHARACTERISTICS

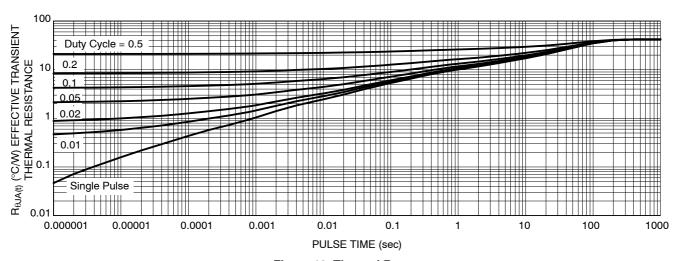
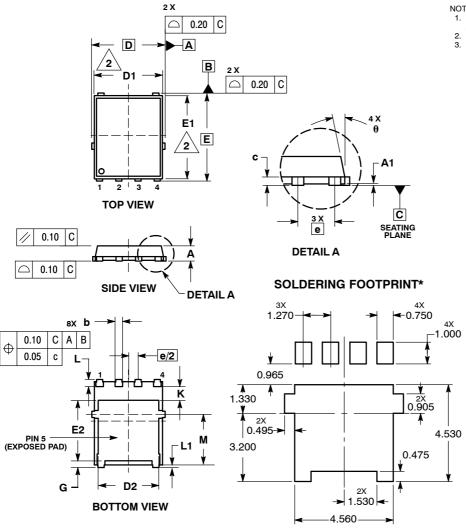


Figure 13. Thermal Response

PACKAGE DIMENSIONS

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA **ISSUE H**



NOTES

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00		0.05		
b	0.33	0.41	0.51		
C	0.23	0.28	0.33		
D		5.15 BSC	;		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E		6.15 BSC	;		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е		1.27 BSC			
G	0.51	0.61	0.71		
K	1.20	1.35	1.50		
L	0.51	0.61	0.71		
L1	0.05	0.17	0.20		
М	3.00	3.40	3.80		
A	0 °		12 °		

STYLE 1:

- PIN 1. SOURCE 2. SOURCE
 - 3. SOURCE
 - GATE DRAIN

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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